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Tomography Sensing Technologies

Guest Editor:

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closed (30 January 2021)

Message from the Guest Editor

Dear Colleagues,

This Special Issue is aiming at international, multidisciplinary studies devoted to all areas of tomographic imaging. The areas of interest include but are not limited to:

- Industrial applications both for process monitoring and material characterization, and nondestructive testing;
- Environmental and geophysical tomography;
- Biological and biomedical tomography;
- Tomography and control.

Areas of interest include all aspects of tomographic imaging, including computational and mathematical aspects, tomographic instrument and sensors, underlying physics, data interpretation and applications, use of tomography in control, and tomography in soft sensors and robotics.

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Prof. Dr. Manuchehr Soleimani Guest Editor













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